AVL Supermicro server platform Memory Module Qualification Test

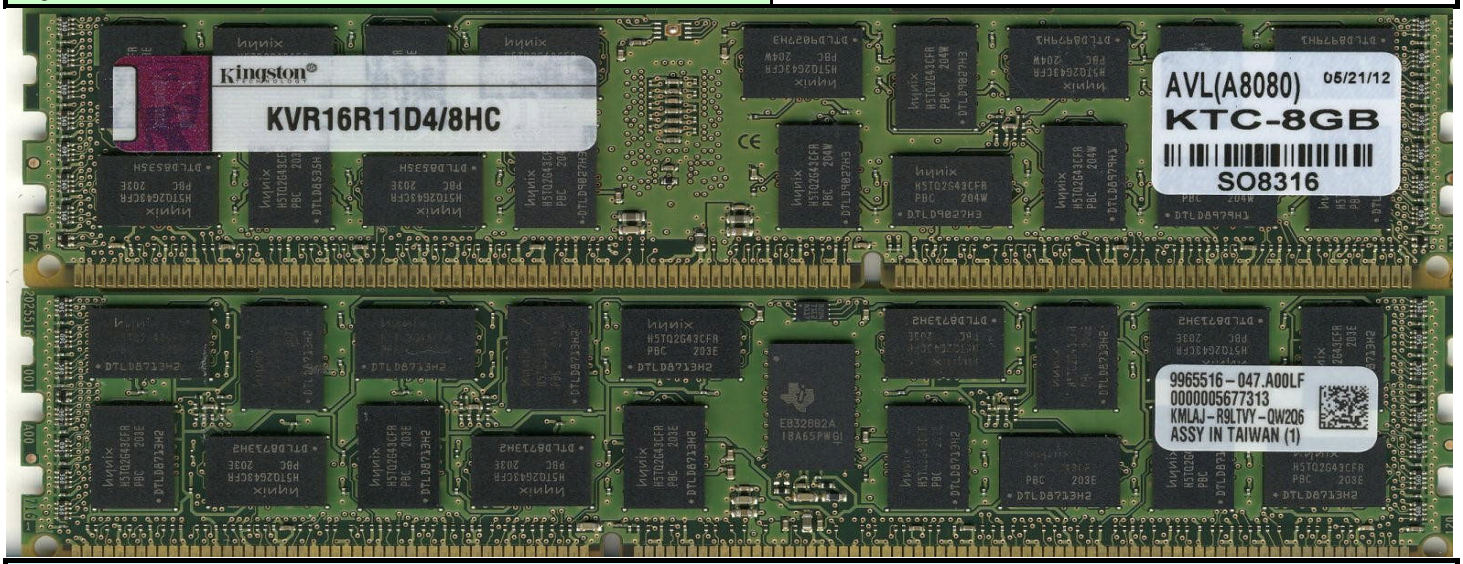
Intel E5-2650(SNB-EP) x 1, Intel C602 | **Test Results** | **Pass**

PN: KVR16R11D4/8HC (8GB / RDIMM / ECC) On: X9SRE-F Rev.0

Module Information

RP77D3x-106-KI-SQ-SMC-V1 — Rev 01/07/2011

AVL WorkOrder #	wc3781	AVL A#	8080
Start Date	6/1/2012	End Date	6/2/2012
Tested By		Van N.	
Module Manufacturer		Kingston	
Module Part Number		KVR16R11D4/8HC	
Module BOM Number		9965516-047.A00LF	
Module Capacity / Memory Type / ECC		8GB / RDIMM / ECC	
Module Configuration (Width, # of devices, # of Ranks)		1Gx72 /36 Devices / 2 Ranks	
Speed Tested (Data rate of Mbps, CL-tRP-tRCD)		DDR3-1600 11-11-11	
DRAM Device Vendor		Hynix	
DRAM Device Part Number / Date code		H5TQ2G43CFR-PBC	1203
DRAM Die Revision / Process Technology (nm)		C	
DRAM Device Config (Density / Width)		2Gbit / x4	
Thermal Sensor Device Vendor / Part Number / Revision		STMicro	
Register Device Vendor / Part Number / Revision		TI	



Platform System Information

Motherboard Info (Model# & MB Revision & MB S/N & AVL S/N)	X9SRE-F	0	0	SO6530
BIOS Revision / BIOS Date	1.0a		3/6/2012	
CPU / Speed	Intel E5-2650(SNB-EP) x 1		2.0GHz	
Chipset info (Stepping)	Intel C602			

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Test Results:	PASS
Comments:	

AVL Memory Module Qual Test Results Summary

Test # and name	Test Description	Specs	Test Results	Comments
1. Latest BIOS Upgrade & Configuration	Download / Upgrade latest BIOS & record size and speed detection		**Done**	
2. SPD Check	Memory module SPD content check for JEDEC compliance	JEDEC	**Pass**	Use proprietary tools
3. Reset Cycle	Run Linux based diags & utility software @ 50°C	50 loops	**Pass**	1 DIMM Per Channel when applicable
4a. Stress Application Test	Run Linux based diags & utility software @50°C	8 Hour per config	**Pass**	DIMM Loading per spec
4b. Stream Benchmark Test		5 loop per config	**Pass**	DIMM Loading per spec
4b. Reset Cycle		200 loop per config	**Pass**	DIMM Loading per spec
5. Functional Stress Test	Memory Stress Test @50°C -	12hrs	**Pass**	DIMM Loading per spec
6. Stress Application Test	Run Linux based diags & utility software @50°C	6hrs	**Pass**	3 DIMM Per Channel when applicable

Note: All test under IMC Vdd=Nom, Vref=Vddnom/2